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				APPLICANTS Nobuyuki Ishikawa et al.					
LIST OF PUBLICATIONS CITED BY APPLICANT (Use several sheets if necessary)				FILING DATE Herewith	FILING DATE		GROUP 1793		
U.S. PATENT DOCUMENTS									
EXAMINER							FILING DA	TE	
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OTHER PUBLICATIONS (Including Author, Title, Date, Pertinent Pages, Etc.)									
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